

FQB34P10 / FQI34P10

P-Channel QFET MOSFET

-100 V, -33.5 A, 60 m Ω

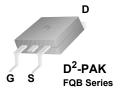
Description

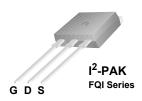
This P-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor $^{\circledR}$ s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.

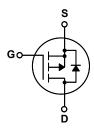


Features

- -33.5 A, -100 V, $R_{DS(on)}$ = 60 m Ω (max) @ V_{GS} = -10 V, $I_D = -16.75 A$
- Low Gate Charge (Typ. 85 nC)
- Low Crss (Typ. 170 pF)
- · 100% Avalanche Tested
- 175°C Maximum Junction Temperature Rating







Absolute Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter		FQB34P10 / FQI34P10	Unit
V_{DSS}	Drain-Source Voltage		-100	V
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		-33.5	Α
			-23.5	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	-134	Α
V _{GSS}	Gate-Source Voltage		± 25	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	2200	mJ
I _{AR}	Avalanche Current	(Note 1)	-33.5	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	15.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-6.0	V/ns
P_{D}	Power Dissipation (T _A = 25°C) *		3.75	W
	Power Dissipation (T _C = 25°C) - Derate above 25°C		155	W
			1.03	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +175	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.97	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

^{*} When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-100			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = -250 μA, Referenced to 25°C		-0.1		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -100 V, V _{GS} = 0 V			-1	μΑ
		V _{DS} = -80 V, T _C = 150°C			-10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = -25 V, V _{DS} = 0 V			-100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = 25 V, V _{DS} = 0 V			100	nA
On Cha	racteristics					
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = -250 μA	-2.0		-4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = -10 V, I _D = -16.75 A		0.049	0.06	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = -40 \text{ V}, I_D = -16.75 \text{ A} \text{ (Note 4)}$		23		S
	Input Capacitance Output Capacitance	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		730	2910 950	pF pF
C _{oss}	Output Capacitance			730	950	pF
C _{rss}	Reverse Transfer Capacitance			170	220	pF
Switchi	ing Characteristics					
t _{d(on)}	Turn-On Delay Time	V _{DD} = -50 V, I _D = -33.5 A,		25	60	ns
t _r	Turn-On Rise Time	$R_{G} = 25 \Omega$		250	510	ns
t _{d(off)}	Turn-Off Delay Time	11.6 20 32		160	330	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		210	430	ns
Qg	Total Gate Charge	V _{DS} = -80 V, I _D = -33.5 A,		85	110	nC
Q _{gs}	Gate-Source Charge	V _{GS} = -10 V		15		nC
Q _{gd}	Gate-Drain Charge	(Note 4, 5)		45	-	nC
Drain-S	Source Diode Characteristics a	nd Maximum Ratings				
I _S	Maximum Continuous Drain-Source Diode Forward Current				-33.5	Α
I _{SM}	Maximum Pulsed Drain-Source Diode F	orward Current			-134	Α
V_{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = -33.5 A			-4.0	V
	Payaraa Pagayary Tima	$V_{GS} = 0 \text{ V}, I_{S} = -33.5 \text{ A},$		160	-	ns
t _{rr}	Reverse Recovery Time	VGS 0 1, 15 00.071,		.00		

- Notes:
 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L =mH, I_{AS} = -33.5A, V_{DD} = -25V, R_C = 25 Ω, Starting T_J = 25°C 3. I_{SD} ≤ -33.5A, di/dt ≤ 300A/μs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C 4. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2% 5. Essentially independent of operating temperature

Typical Characteristics

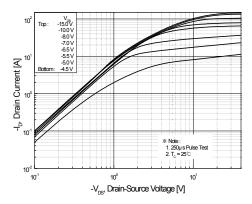


Figure 1. On-Region Characteristics

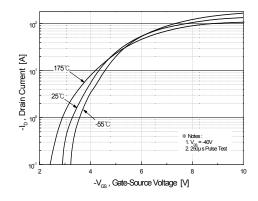


Figure 2. Transfer Characteristics

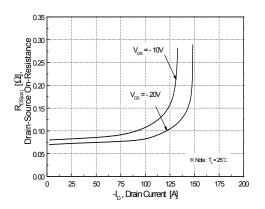


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

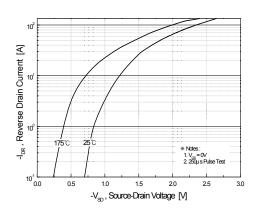


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

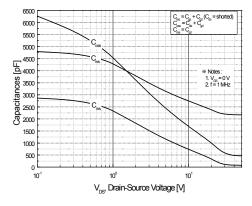


Figure 5. Capacitance Characteristics

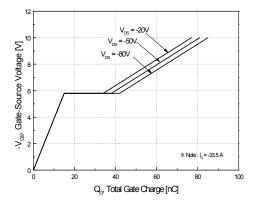


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

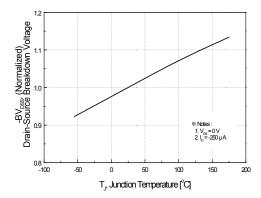


Figure 7. Breakdown Voltage Variation vs. Temperature

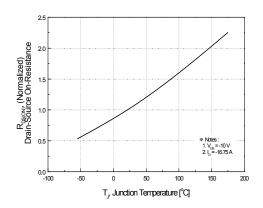


Figure 8. On-Resistance Variation vs. Temperature

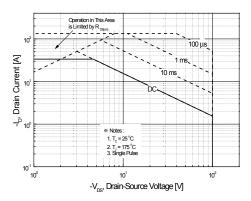


Figure 9. Maximum Safe Operating Area

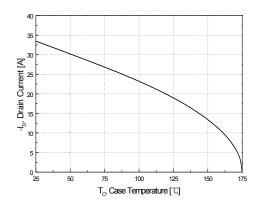


Figure 10. Maximum Drain Current vs. Case Temperature

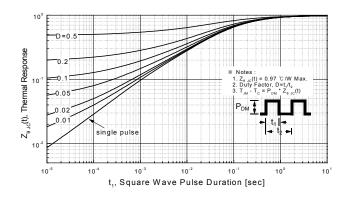
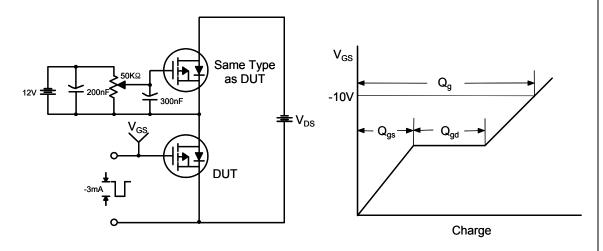
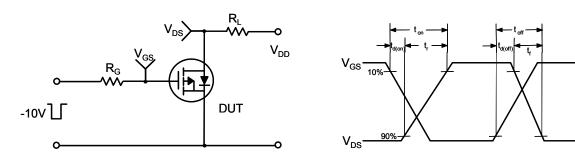


Figure 11. Transient Thermal Response Curve

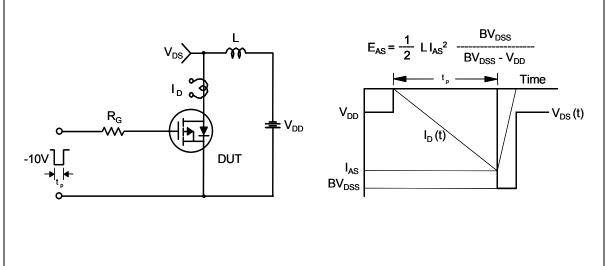
Gate Charge Test Circuit & Waveform



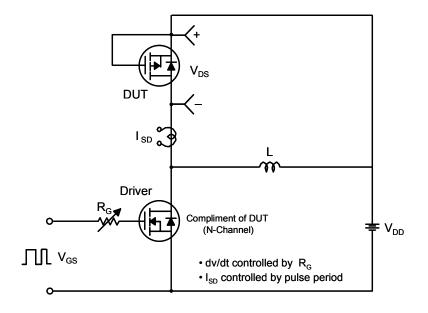
Resistive Switching Test Circuit & Waveforms

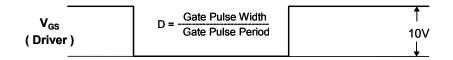


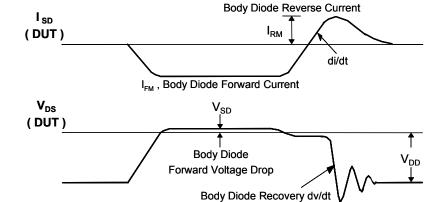
Unclamped Inductive Switching Test Circuit & Waveforms

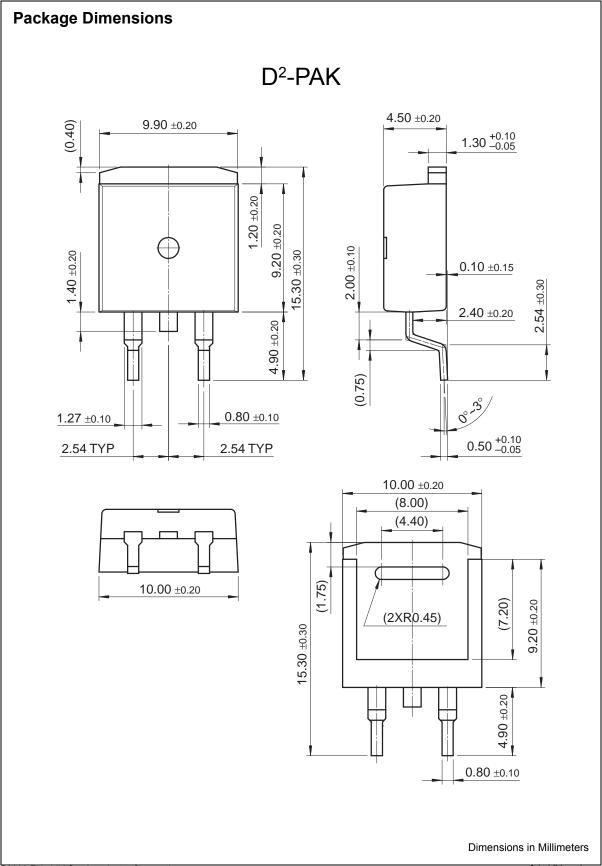


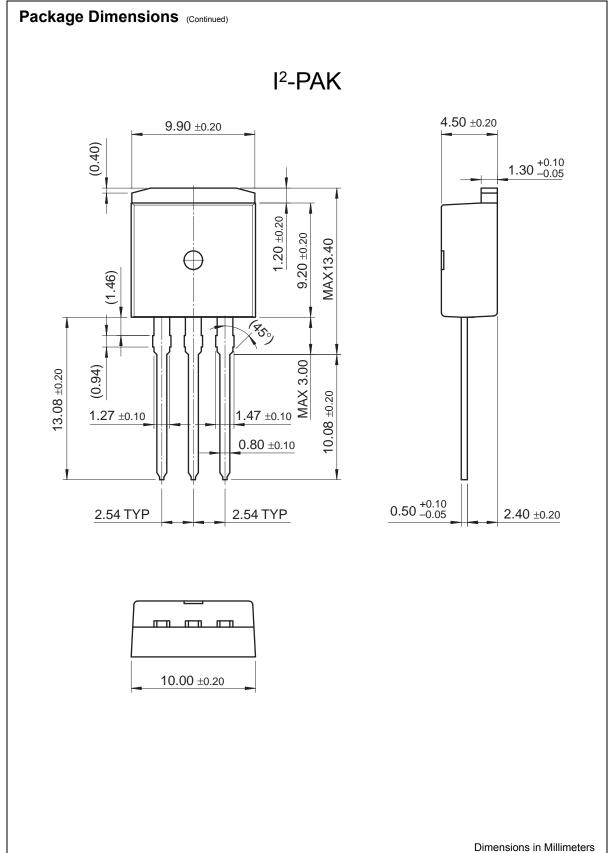
Peak Diode Recovery dv/dt Test Circuit & Waveforms















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